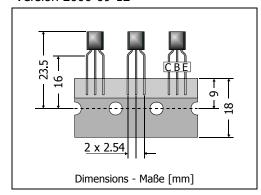


PNP Si-Epitaxial-Planar Switching Transistors PNP Si-Epitaxial-Planar Schalttransistoren

Version 2006-09-12



Power dissipation 625 mW Verlustleistung

Plastic case TO-92 Kunststoffgehäuse (10D3)

Weight approx. – Gewicht ca. 0.18 g

Plastic material has UL classification 94V-0 Gehäusematerial UL94V-0 klassifiziert

Standard packaging taped in ammo pack Standard Lieferform gegurtet in Ammo-Pack



Maximum ratings $(T_A = 25^{\circ}C)$

Grenzwerte ($T_A = 25$ °C)

			2N3906
Collector-Emitter-volt. – Kollektor-Emitter-Spannung	B open	- V _{CEO}	40 V
Collector-Base-voltage – Kollektor-Basis-Spannung	E open	- V _{CBO}	40 V
Emitter-Base-voltage – Emitter-Basis-Spannung	C open	- V _{EBO}	5 V
Power dissipation – Verlustleistung		P _{tot}	625 mW ¹)
Collector current – Kollektorstrom (dc)		- I _C	200 mA
Junction temperature – Sperrschichttemperatur Storage temperature – Lagerungstemperatur		T _j T _S	-55+150°C -55+150°C

Characteristics ($T_j = 25$ °C)

Kennwerte ($T_j = 25$ °C)

		Min.	Тур.	Max.
DC current gain – Kollektor-Basis-Stromverhältnis ²)				
$- I_{C} = 0.1 \text{ mA, } - V_{CE} = 1 \text{ V}$	h _{FE}	60	_	_
$- I_C = 1 \text{ mA}, - V_{CE} = 1 \text{ V}$	h_{FE}	80	_	_
$- I_C = 10 \text{ mA}, - V_{CE} = 1 \text{ V}$	h_{FE}	100	_	300
$- I_{C} = 50 \text{ mA}, - V_{CE} = 1 \text{ V}$	h_{FE}	60	_	_
$- I_C = 100 \text{ mA}, - V_{CE} = 1 \text{ V}$	h _{FE}	30	-	-
Collector-Emitter saturation voltage – Kollektor-Emitter-Sättigungsspg. ²)				
$- I_C = 10 \text{ mA}, - I_B = 1 \text{ mA}$	- V _{CEsat}	_	_	0.25 V
$- I_C = 50 \text{ mA}, - I_B = 5 \text{ mA}$	- V _{CEsat}	_	-	0.40 V
Base-Emitter saturation voltage – Basis-Emitter-Sättigungsspannung ²)				
$- I_{C} = 10 \text{ mA}, - I_{B} = 1 \text{ mA}$	- V _{BEsat}	0.65 V	_	0.85 V
$- I_{C} = 50 \text{ mA}, - I_{B} = 5 \text{ mA}$	- V _{BEsat}	_	-	0.95 V

Mounted on P.C. board with 3 mm² copper pad at each terminal Montage auf Leiterplatte mit 3 mm² Kupferbelag (Lötpad) an jedem Anschluss

² Tested with pulses $t_p = 300~\mu s$, duty cycle $\leq 2\%$ — Gemessen mit Impulsen $t_p = 300~\mu s$, Schaltverhältnis $\leq 2\%$



Characteristics ($T_j = 25$ °C)

Kennwerte ($T_j = 25$ °C)

			Min.	Тур.	Max.
Collector-Emitter cutoff current – Kollek	ktor-Emitter-Reststrom				
$- V_{CE} = 30 V, - V_{EB} = 3 V$		- I _{CBX}	_	_	50 nA
Emitter-Base cutoff current – Emitter-B	asis-Reststrom	•			
- V _{CE} = 30 V, - V _{EB} = 3 V		- I _{EBV}	_		50 nA
Gain-Bandwidth Product – Transitfrequ	enz	•			
$- I_{C} = 10 \text{ mA}, - V_{CE} = 20 \text{ V}, f = 100 \text{ MHz}$		f _T	250 MHz	_	_
Collector-Base Capacitance – Kollektor-	Basis-Kapazität	•			
- V_{CB} = 5 V, I_E = i_e = 0, f = 1 MHz	$5 \text{ V, } I_E = i_e = 0, f = 1 \text{ MHz}$		_	_	4.5 pF
Emitter-Base Capacitance – Emitter-Base	sis-Kapazität	•			
$- V_{EB} = 0.5 \text{ V}, I_{C} = i_{c} = 0, f = 1 \text{ MHz}$		C _{EBO}	_	_	10 pf
Noise figure – Rauschzahl					
- V_{CE} = 5 V, - I_C = 100 μ A, R_G = 1 $k\Omega$, f = 1 kHz		F	_	_	4 dB
Switching times – Schaltzeiten (betwee	n 10% and 90% levels)	•			
delay time - V_{CC}	$ - V_{CC} = 3 \text{ V, } - V_{BE} = 0.5 \text{ V} $ $- I_{C} = 10 \text{ mA, } - I_{B1} = 1 \text{mA} $	t _d	_	_	35 ns
rise time - I _C		t _r	_	_	35 ns
storage time - V _{cc}	$-$ - V_{CC} = 3 V, - I_{C} = 10 mA, - I_{B1} = - I_{B2} = 1 mA	ts	_	_	225 ns
		t _f	_	-	75 ns
Thermal resistance junction to ambient Wärmewiderstand Sperrschicht – umge		R _{thA}	< 200 K/W ¹)		·)
ecommended complementary NPN transistors mpfohlene komplementäre NPN-Transistoren 2N3904					

Mounted on P.C. board with 3 mm² copper pad at each terminal Montage auf Leiterplatte mit 3 mm² Kupferbelag (Lötpad) an jedem Anschluss